# **Power MOSFET**

# 30 V, 79 A, Single N-Channel, DPAK/IPAK

#### **Features**

- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- These are Pb-Free Devices

#### **Applications**

- CPU Power Delivery
- DC-DC Converters

#### **MAXIMUM RATINGS** (T<sub>J</sub> = 25°C unless otherwise noted)

| Parar  | Symbol                            | Value                  | Unit                 |      |   |
|--|-----------------------------------|------------------------|----------------------|------|---|
| Drain-to-Source Volta  | V <sub>DSS</sub>                  | 30                     | V                    |      |   |
| Gate-to-Source Volta   | Gate-to-Source Voltage            |                        |                      |      | V |
| Continuous Drain<br>Current (R <sub>0.1A</sub> )   |                                   | T <sub>A</sub> = 25°C  | V <sub>GS</sub>      | 17.8 | Α |
| (Note 1)   |                                   | T <sub>A</sub> = 100°C |                      | 12.6 |   |
| Power Dissipation (R <sub>θJA</sub> ) (Note 1)   |                                   | T <sub>A</sub> = 25°C  | P <sub>D</sub>       | 2.6  | W |
| Continuous Drain<br>Current (R <sub>0.IA</sub> ) (Note   |                                   | T <sub>A</sub> = 25°C  | I <sub>D</sub>       | 13   | Α |
| 2)   | Steady                            | T <sub>A</sub> = 100°C |                      | 9.2  |   |
| Power Dissipation (R <sub>θJA</sub> ) (Note 2)   | State                             | T <sub>A</sub> = 25°C  | P <sub>D</sub>       | 1.4  | W |
| Continuous Drain   |                                   | T <sub>C</sub> = 25°C  | I <sub>D</sub>       | 79   | Α |
| Current (R <sub>θJC</sub> )<br>(Note 1)  |                                   | T <sub>C</sub> = 100°C |                      | 56   |   |
| Power Dissipation (R <sub>θJC</sub> ) (Note 1)   |                                   | T <sub>C</sub> = 25°C  | P <sub>D</sub>       | 52   | W |
| Pulsed Drain Current   | t <sub>p</sub> =10μs              | T <sub>A</sub> = 25°C  | I <sub>DM</sub>      | 316  | Α |
| Current Limited by Pac   | kage                              | T <sub>A</sub> = 25°C  | I <sub>DmaxPkg</sub> | 90   | Α |
| Operating Junction and   | T <sub>J</sub> , T <sub>stg</sub> | -55 to<br>175          | °C                   |      |   |
| Source Current (Body I   | I <sub>S</sub>                    | 47                     | Α                    |      |   |
| Drain to Source dV/dt  | dV/dt                             | 6.0                    | V/ns                 |      |   |
| Single Pulse Drain-to-<br>Energy (T <sub>J</sub> = 25°C, V <sub>DI</sub><br>L = 0.1 mH, $I_{L(pk)}$ = 37 | E <sub>AS</sub>                   | 68.4                   | mJ                   |      |   |
| Lead Temperature for S (1/8" from case for 10 s  | TL                                | 260                    | °C                   |      |   |

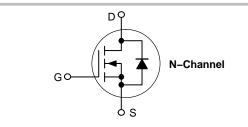
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.



#### ON Semiconductor®

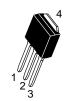
#### http://onsemi.com

| V <sub>(BR)DSS</sub> | R <sub>DS(on)</sub> MAX                  | I <sub>D</sub> MAX |
|----------------------|--|--------------------|
| 30 V                 | $3.7~\mathrm{m}\Omega$ @ $10~\mathrm{V}$ | 79 A               |
| 30 V                 | 5.5 mΩ @ 4.5 V                           | 131                |







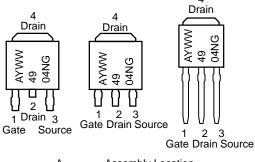


CASE 369AA **DPAK** (Bent Lead) STYLE 2

CASE 369AD **IPAK** (Straight Lead) (Straight Lead

CASE 369D **IPAK** DPAK)

### **MARKING DIAGRAMS** & PIN ASSIGNMENTS



= Assembly Location = Year

WW = Work Week 4904N = Device Code = Pb-Free Package

### **ORDERING INFORMATION**

See detailed ordering and shipping information in the package dimensions section on page 6 of this data sheet.

#### THERMAL RESISTANCE MAXIMUM RATINGS

| Parameter                                   | Symbol              | Value | Unit |
|---|---------------------|-------|------|
| Junction-to-Case (Drain)                    | $R_{	heta JC}$      | 2.9   | °C/W |
| Junction-to-Tab (Drain)                     | $R_{\theta JC-TAB}$ | 4.3   |      |
| Junction-to-Ambient - Steady State (Note 1) | $R_{	heta JA}$      | 57    |      |
| Junction-to-Ambient - Steady State (Note 2) | $R_{	heta JA}$      | 108   |      |

- Surface–mounted on FR4 board using 1 in sq pad size, 1 oz Cu.
   Surface–mounted on FR4 board using the minimum recommended pad size.

## **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise noted)

| Parameter  | Symbol                               | Test Con  | dition                 | Min | Тур  | Max  | Unit  |
|--|--------------------------------------|---|------------------------|-----|------|------|-------|
| OFF CHARACTERISTICS  |                                      |   | •                      |     |      |      | _I    |
| Drain-to-Source Breakdown Voltage                            | V <sub>(BR)DSS</sub>                 | $V_{GS} = 0 \text{ V}, I_{D} = 250 \mu\text{A}$                         |                        | 30  |      |      | V     |
| Drain-to-Source Breakdown Voltage<br>Temperature Coefficient | V <sub>(BR)DSS</sub> /T <sub>J</sub> |   | ·                      |     | 15   |      | mV/°C |
| Zero Gate Voltage Drain Current                              | I <sub>DSS</sub>                     | V <sub>GS</sub> = 0 V,  | T <sub>J</sub> = 25°C  |     |      | 1.0  | μΑ    |
|  |                                      | $V_{DS} = 24 \text{ V}$   | T <sub>J</sub> = 125°C |     |      | 10   | 1     |
| Gate-to-Source Leakage Current                               | I <sub>GSS</sub>                     | $V_{DS} = 0 \text{ V}, V_{GS}$  | <sub>S</sub> = ±20 V   |     |      | ±100 | nA    |
| ON CHARACTERISTICS (Note 3)                                  |                                      |   |                        |     | -    | •    |       |
| Gate Threshold Voltage                                       | V <sub>GS(TH)</sub>                  | $V_{GS} = V_{DS}, I_{D}$  | _ = 250 μΑ             | 1.0 | 1.6  | 2.2  | V     |
| Negative Threshold Temperature Coefficient                   | V <sub>GS(TH)</sub> /T <sub>J</sub>  |   |                        |     | 4.0  |      | mV/°C |
| Drain-to-Source On Resistance                                | R <sub>DS(on)</sub>                  | V <sub>GS</sub> = 10 V  | I <sub>D</sub> = 30 A  |     | 3.0  | 3.7  | mΩ    |
|  |                                      |   | I <sub>D</sub> = 15 A  |     | 3.0  |      | 1     |
|  |                                      | V <sub>GS</sub> = 4.5 V   | I <sub>D</sub> = 30 A  |     | 4.0  | 5.5  | 1     |
|  |                                      |   | I <sub>D</sub> = 15 A  |     | 4.0  |      | 1     |
| Forward Transconductance                                     | gFS                                  | V <sub>DS</sub> = 1.5 V, I <sub>D</sub> = 30 A                          |                        |     | 76   |      | S     |
| CHARGES AND CAPACITANCES                                     | <u> </u>                             |   | <u>.</u>               |     | 1    | I    |       |
| Input Capacitance  | C <sub>iss</sub>                     | $V_{GS} = 0 \text{ V, f} = 1.0 \text{ MHz,}$<br>$V_{DS} = 15 \text{ V}$ |                        |     | 3052 |      | pF    |
| Output Capacitance   | C <sub>oss</sub>                     |   |                        |     | 976  |      | 1     |
| Reverse Transfer Capacitance                                 | C <sub>rss</sub>                     | V <sub>DS</sub> = 1   | 5 V                    |     | 23   |      | 1     |
| Total Gate Charge  | Q <sub>G(TOT)</sub>                  |   |                        |     | 16.8 |      | nC    |
| Threshold Gate Charge  | Q <sub>G(TH)</sub>                   | $V_{GS} = 4.5 \text{ V}, V_{DS} = 15 \text{ V},$                        |                        |     | 4.4  |      | 1     |
| Gate-to-Source Charge  | Q <sub>GS</sub>                      | $I_D = 30$  |                        |     | 8.2  |      | 7     |
| Gate-to-Drain Charge   | $Q_GD$                               |   | ľ                      |     | 3.0  |      | 1     |
| Total Gate Charge  | $Q_{G(TOT)}$                         | $V_{GS} = 10 \text{ V}, V_{DS} = 15 \text{ V},$ $I_{D} = 30 \text{ A}$  |                        |     | 41   |      | nC    |
| SWITCHING CHARACTERISTICS (Note                              | e 4)                                 |   | •                      |     | •    |      | •     |
| Turn-On Delay Time   | t <sub>d(on)</sub>                   |   |                        |     | 15.3 |      | ns    |
| Rise Time  | t <sub>r</sub>                       | V <sub>GS</sub> = 4.5 V, V  | 'ns = 15 V.            |     | 19.8 |      | 1     |
| Turn-Off Delay Time  | t <sub>d(off)</sub>                  | $I_D = 15 \text{ A}, R_C$   |                        |     | 23.4 |      | 1     |
| Fall Time  | t <sub>f</sub>                       |   | ļ                      |     | 7.5  |      | 1     |
| Turn-On Delay Time   | t <sub>d(on)</sub>                   |   |                        |     | 10.3 |      | ns    |
| Rise Time  | t <sub>r</sub>                       | V <sub>GS</sub> = 10 V, V   | ns = 15 V.             |     | 20   |      | 1     |
| Turn-Off Delay Time  | t <sub>d(off)</sub>                  | $I_D = 15 \text{ A}, R_G = 3.0 \Omega$                                  |                        |     | 28.7 |      | 1     |
| Fall Time  | t <sub>f</sub>                       |   |                        |     | 8.0  |      | 1     |

- Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
   Switching characteristics are independent of operating junction temperatures.

## **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise noted)

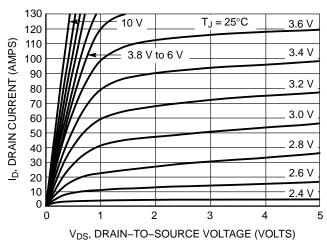
| Parameter                       | Symbol          | Test Condition                 |  | Min | Тур    | Max | Unit |
|---------------------------------|-----------------|--------------------------------|--|-----|--------|-----|------|
| DRAIN-SOURCE DIODE CHARACTERI   | STICS           | •                              |  |     |        |     |      |
| Forward Diode Voltage           | V <sub>SD</sub> | $V_{GS} = 0 V$ ,               | $T_J = 25^{\circ}C$                      |     | 0.84   | 1.1 | V    |
|                                 |                 | I <sub>S</sub> = 30 A          | T <sub>J</sub> = 125°C                   |     | 0.7    |     |      |
| Reverse Recovery Time           | t <sub>RR</sub> |                                | •  |     | 40.4   |     | ns   |
| Charge Time                     | ta              | $V_{GS} = 0 \text{ V, dls}$    | V <sub>GS</sub> = 0 V, dls/dt= 100 A/μs, |     | 20.5   |     |      |
| Discharge Time                  | tb              | I <sub>S</sub> = 30 A          |  |     | 19.9   |     |      |
| Reverse Recovery Time           | $Q_{RR}$        |                                |  |     | 35     |     | nC   |
| PACKAGE PARASITIC VALUES        |                 |                                |  |     |        |     |      |
| Source Inductance (Note 5)      | L <sub>S</sub>  |                                |  |     | 2.48   |     | nΗ   |
| Drain Inductance, DPAK          | L <sub>D</sub>  | 1                              |  |     | 0.0164 |     |      |
| Drain Inductance, IPAK (Note 5) | L <sub>D</sub>  | T <sub>A</sub> = 25°C 1.88 4.9 |  |     |        |     |      |
| Gate Inductance (Note 5)        | L <sub>G</sub>  |                                |  |     |        |     |      |
| Gate Resistance                 | R <sub>G</sub>  | 1                              |  |     | 1.0    | 2.0 | Ω    |

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

5. Assume terminal length of 110 mils.

#### **TYPICAL PERFORMANCE CURVES**

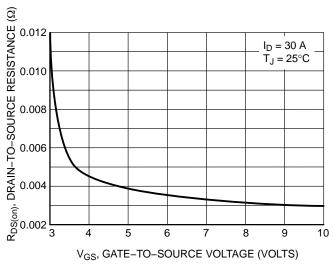
130



 $V_{DS} \ge 10 \text{ V}$ 120 110 DRAIN CURRENT (AMPS) 100 90 80 70 60  $T_J = 125^{\circ}C$ 50 40  $T_J = 25^{\circ}C$ 30 ے 20  $T_J = -55^{\circ}C$ 2.5 3 2 3.5 V<sub>GS</sub>, GATE-TO-SOURCE VOLTAGE (VOLTS)

Figure 1. On-Region Characteristics

Figure 2. Transfer Characteristics



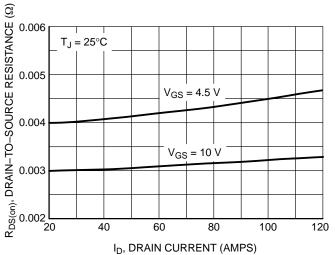
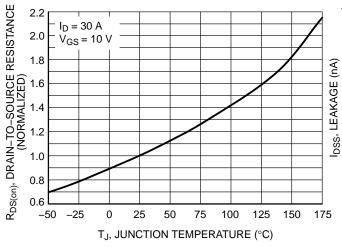


Figure 3. On-Resistance vs. Gate-to-Source Voltage

Figure 4. On–Resistance vs. Drain Current and Gate Voltage



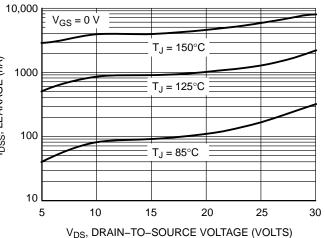


Figure 5. On–Resistance Variation with Temperature

Figure 6. Drain-to-Source Leakage Current vs. Drain Voltage

#### **TYPICAL PERFORMANCE CURVES**

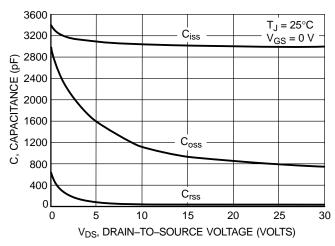


Figure 7. Capacitance Variation

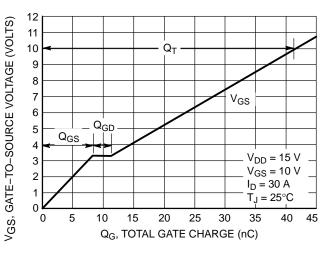


Figure 8. Gate-To-Source and Drain-To-Source Voltage vs. Total Charge

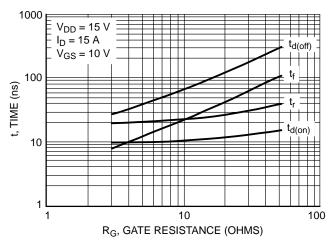


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

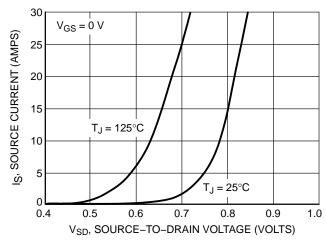


Figure 10. Diode Forward Voltage vs. Current

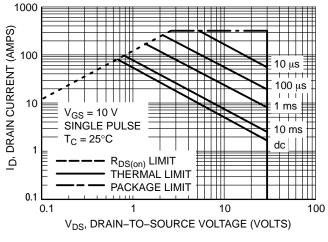


Figure 11. Maximum Rated Forward Biased Safe Operating Area

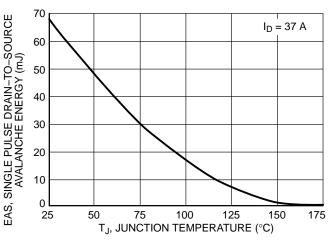


Figure 12. Maximum Avalanche Energy vs. Starting Junction Temperature

#### **TYPICAL PERFORMANCE CURVES**

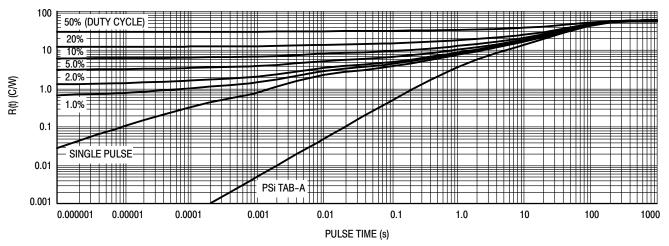


Figure 13. FET Thermal Response

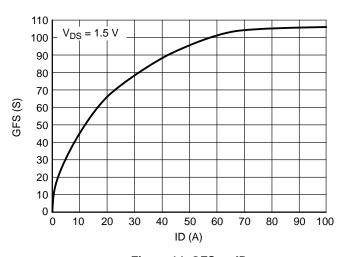


Figure 14. GFS vs ID

#### **ORDERING INFORMATION**

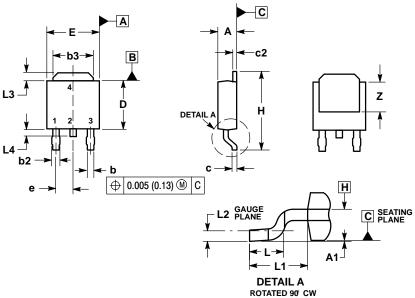
| Order Number | Package                        | Shipping <sup>†</sup> |
|--------------|--------------------------------|-----------------------|
| NTD4904NT4G  | DPAK<br>(Pb-Free)              | 2500 / Tape & Reel    |
| NTD4904N-1G  | IPAK<br>(Pb-Free)              | 75 Units / Rail       |
| NTD4904N-35G | IPAK Trimmed Lead<br>(Pb-Free) | 75 Units / Rail       |

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

#### PACKAGE DIMENSIONS

# **DPAK (SINGLE GUAGE)**

CASE 369AA **ISSUE B** 



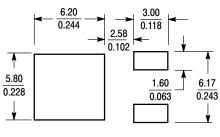
- NOTES:
  1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
  2. CONTROLLING DIMENSION: INCHES.
  3. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSIONS b3, L3 and Z.
  4. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL NOT EXCEED 0.006 INCHES PER SIDE.
  5. DIMENSIONS D AND E ARE DETERMINED AT THE

  - DIMENSIONS D AND E ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
     DATUMS A AND B ARE DETERMINED AT DATUM PLANE H.

|     | INCHES |       | MILLIM   | ETERS |
|-----|--------|-------|----------|-------|
| DIM | MIN    | MAX   | MIN      | MAX   |
| Α   | 0.086  | 0.094 | 2.18     | 2.38  |
| A1  | 0.000  | 0.005 | 0.00     | 0.13  |
| b   | 0.025  | 0.035 | 0.63     | 0.89  |
| b2  | 0.030  | 0.045 | 0.76     | 1.14  |
| b3  | 0.180  | 0.215 | 4.57     | 5.46  |
| С   | 0.018  | 0.024 | 0.46     | 0.61  |
| c2  | 0.018  | 0.024 | 0.46     | 0.61  |
| D   | 0.235  | 0.245 | 5.97     | 6.22  |
| E   | 0.250  | 0.265 | 6.35     | 6.73  |
| е   | 0.090  | BSC   | 2.29     | BSC   |
| Н   | 0.370  | 0.410 | 9.40     | 10.41 |
| L   | 0.055  | 0.070 | 1.40     | 1.78  |
| L1  | 0.108  | REF   | 2.74 REF |       |
| L2  | 0.020  | BSC   | 0.51     | BSC   |
| L3  | 0.035  | 0.050 | 0.89     | 1.27  |
| L4  |        | 0.040 |          | 1.01  |
| Z   | 0.155  |       | 3.93     |       |

STYLE 2: PIN 1. GATE 2. DRAIN 3. SOURCE 4. DRAIN

#### **SOLDERING FOOTPRINT\***



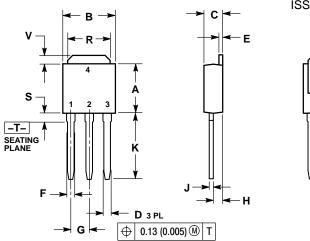
SCALE 3:1

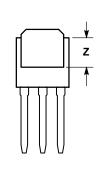
<sup>\*</sup>For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

#### PACKAGE DIMENSIONS

#### **IPAK (STRAIGHT LEAD DPAK)**

CASE 369D **ISSUE C** 





#### NOTES:

- DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
- 2. CONTROLLING DIMENSION: INCH.

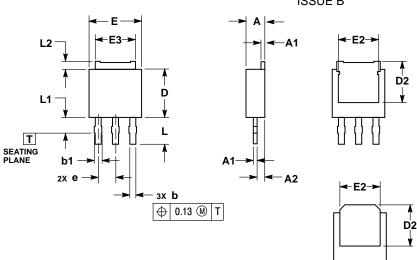
|     | INCHES |       | MILLIN   | IETERS |
|-----|--------|-------|----------|--------|
| DIM | MIN    | MAX   | MIN      | MAX    |
| Α   | 0.235  | 0.245 | 5.97     | 6.35   |
| В   | 0.250  | 0.265 | 6.35     | 6.73   |
| С   | 0.086  | 0.094 | 2.19     | 2.38   |
| D   | 0.027  | 0.035 | 0.69     | 0.88   |
| Е   | 0.018  | 0.023 | 0.46     | 0.58   |
| F   | 0.037  | 0.045 | 0.94     | 1.14   |
| G   | 0.090  | BSC   | 2.29 BSC |        |
| Н   | 0.034  | 0.040 | 0.87     | 1.01   |
| J   | 0.018  | 0.023 | 0.46     | 0.58   |
| K   | 0.350  | 0.380 | 8.89     | 9.65   |
| R   | 0.180  | 0.215 | 4.45     | 5.45   |
| S   | 0.025  | 0.040 | 0.63     | 1.01   |
| ٧   | 0.035  | 0.050 | 0.89     | 1.27   |
| Z   | 0.155  |       | 3.93     |        |

# STYLE 2:

PIN 1. GATE

- 2 DRAIN
- 3. SOURCE DRAIN

3.5 MM IPAK, STRAIGHT LEAD CASE 369AD **ISSUE B** 



- DIMENSIONING AND TOLERANCING PER
   ASME Y14.5M, 1994.
- CONTROLLING DIMENSION: MILLIMETERS.
  DIMENSION & APPLIES TO PLATED TERMINAL AND IS MEASURED BETWEEN 0.15 AND 0.30mm FROM TERMINAL TIP.
- DIMENSIONS D AND E DO NOT INCLUDE MOLD GATE OR MOLD FLASH.

|     | MILLIMETERS |      |  |  |  |
|-----|-------------|------|--|--|--|
| DIM | MIN         | MAX  |  |  |  |
| Α   | 2.19        | 2.38 |  |  |  |
| A1  | 0.46        | 0.60 |  |  |  |
| A2  | 0.87        | 1.10 |  |  |  |
| b   | 0.69        | 0.89 |  |  |  |
| b1  | 0.77        | 1.10 |  |  |  |
| D   | 5.97        | 6.22 |  |  |  |
| D2  | 4.80        |      |  |  |  |
| Е   | 6.35        | 6.73 |  |  |  |
| E2  | 4.57        | 5.45 |  |  |  |
| E3  | 4.45        | 5.46 |  |  |  |
| е   | 2.28        | BSC  |  |  |  |
| L   | 3.40        | 3.60 |  |  |  |
| L1  |             | 2.10 |  |  |  |
| L2  | 0.89        | 1.27 |  |  |  |
|     |             |      |  |  |  |

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